

# REQUEST FOR CONTINUED EXAMINATION (RCE)

## TRANSMITTAL

Subsection (b) of 35 U.S.C. § 413, effective on May 29, 2000, provides for the continued examination of a utility or plant application filed on or after June 8, 1995.

AUG 28 2000  
U.S. PATENT OFFICE

Application Number	09/529,816
Filing Date	July 31, 2000
First Named Inventor	Emeric THIBIERGE
Group Art Unit	1731
Name of Examiner	CHIN, P.
Attorney Docket No.	000531

This is a Request for Continued Examination (RCE) under 37 C.F.R. § 1.114 of the above-identified application.

**Note:** 37 C.F.R. § 1.114 is effective on May 29, 2000. If the above-identified application was filed prior to May 29, 2000, applicant may wish to consider filing a continued prosecution application (CPA) under 37 C.F.R. § 1.53 (PTO/SB/29) instead of a RCE to be eligible for the patent term adjustment provisions of the AIPA. See changes to Application Examination and Provisional Application Practice, Interim Rule, 65 Fed. Reg. 14865 (Mar 20, 2000) 1233 Off. Gazette Pat Office (April 11, 2000) which established RCE practice.

### 1. Submission Required Under 37 C.F.R. § 1.114

#### a. ☐ Previously submitted

- ☐ Consider the amendment(s)/reply under 37 C.F.R. § 1.116 previously filed on \_\_\_\_\_  
(Any unentered amendment(s) referred to above will be entered)
- ☐ Consider the arguments in the Appeal Brief or Reply Brief previously filed on \_\_\_\_\_
- ☐ Other \_\_\_\_\_

#### b. ☒ Enclosed

- ☒ Amendment
- ☐ Affidavit(s)/Declaration(s)
- ☐ Information Disclosure Statement (IDS)
- ☐ Other:

### 2. Miscellaneous

- ☐ Suspension of Action on the above-identified application is requested under 37 C.F.R. § 1.103(c) for a period of \_\_\_\_\_ months (period shall not exceed three months; Fee under 37 C.F.R. § 1.17(i) required)
- ☐ Other \_\_\_\_\_

### 3. Fees The RCE fee under 37 C.F.R. § 1.17(e) is required by 37 C.F.R. § 1.114 when the RCE is filed.

- ☒ A check in the amount of \$375.00 is enclosed to cover the basic filing fee of \$375.00 for a small entity.
- ☒ The Director is hereby authorized to charge the following fees, or credit any overpayments, to Deposit Account No. 01-2340
  - ☐ RCE fee required under 37 C.F.R. § 1.17 (e)
  - ☐ Extension of Time Fee (37 C.F.R. §§ 1.136 and 1.17)
  - ☒ Other additional extension of time fee or any other additional fee.

**REQUEST FOR  
CONTINUED EXAMINATION (RCE)  
TRANSMITTAL**

Subsection (b) of 35 U.S.C. § 132, effective on May 19, 2000, provides for the continued examination of a utility or plant application filed on or after June 8, 1995.

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Filing Date	July 31, 2000
First Named Inventor	Emeric THIBIERGE
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Attorney Docket No.	000531

**SIGNATURE BY APPLICANT, ATTORNEY, OR AGENT REQUIRE**

Name Nicolas E. Seckel

Registration No. (atty/agent) 44,373

Signature

Date: August 28, 2003

**CERTIFICATE OF MAILING OR TRANSMISSION**

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to Commissioner for Patents, BOX RCE, Washington, D.C. 20231, or facsimile transmitted to the U.S. Patent and Trademark Office on:

Name

Signature



Atty. Docket: 000531

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

Emeric THIBIERGE et al.

Serial Number: 09/529,816

Group Art Unit: 1731

Filed: July 31, 2000

Examiner: CHIN, P.

For: PAPER COMPRISING AN EMBOSSED PATTERN, METHOD FOR PRODUCING AND CLOTH FOR MAKING SAME

**AMENDMENT UNDER 37 C.F.R. 1.114**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

August 28, 2003

Sir:

In response to the Office Action dated March 12, 2003, the Applicants respectfully request that the present application be amended as follows, and the rejection of record be reconsidered in view of the amendments and the following remarks.

Amendments to the Claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks begin on page 7 of this paper.

A Request for Continued Examination is submitted with this paper.